RISC Microprocessor Multichip Package *PRELIMINARY OVERVIEW The WED3C7410E16M-400BX is of

The WEDC 7410E/SSRAM multichip package is targeted for high performance, space sensitive, low power systems and supports the following power management features: doze, nap, sleep and dynamic power management.

The WED3C7410E16M-400BX multichip package consists of:

- 7410E AltiVec™ RISC processor
- Dedicated 2MB SSRAM L2 cache, configured as 256Kx72
- 21mmx25mm, 255 Ceramic Ball Grid Array (CBGA)
- Maximum Core frequency = 400MHz @ 1.8V
- Maximum L2 Cache frequency = 200MHz
- Maximum 60x Bus frequency = 100MHz

The WED3C7410E16M-400BX is offered in Commercial (0°C to +70°C), industrial (-40°C to +85°C) and military (-55°C to +125°C) temperature ranges and is well suited for embedded applications such as missiles, aerospace, flight computers, fire control systems and rugged critical systems.

*This data sheet describes a product that is developmental, is not qualified or characterized and is subject to change without notice.

FEATURES

- Footprint compatible with WED3C7558M-XBX and WED3C750A8M-200BX
- Implementation of Altivec[™] technology instruction set
- Optional, high-bandwidth MPX bus interface

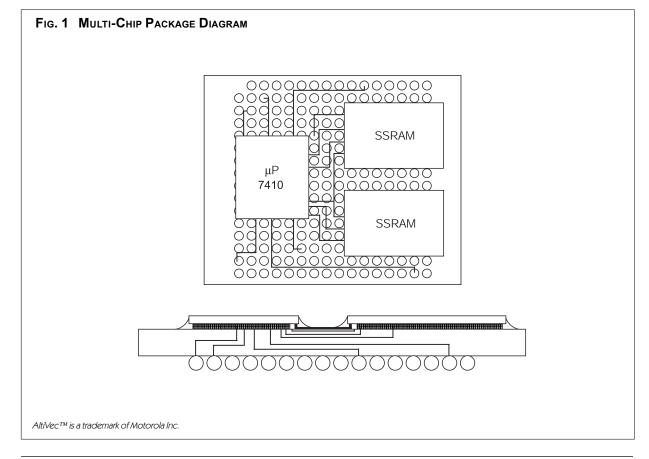
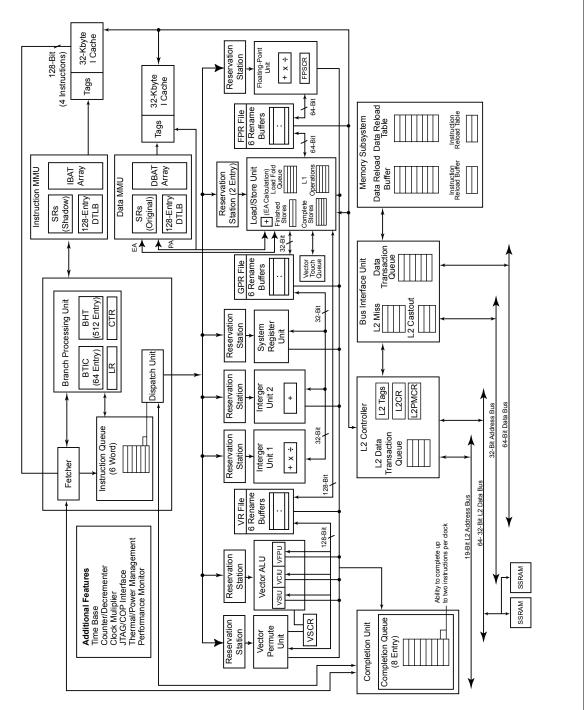


FIG. 2 BLOCK DIAGRAM



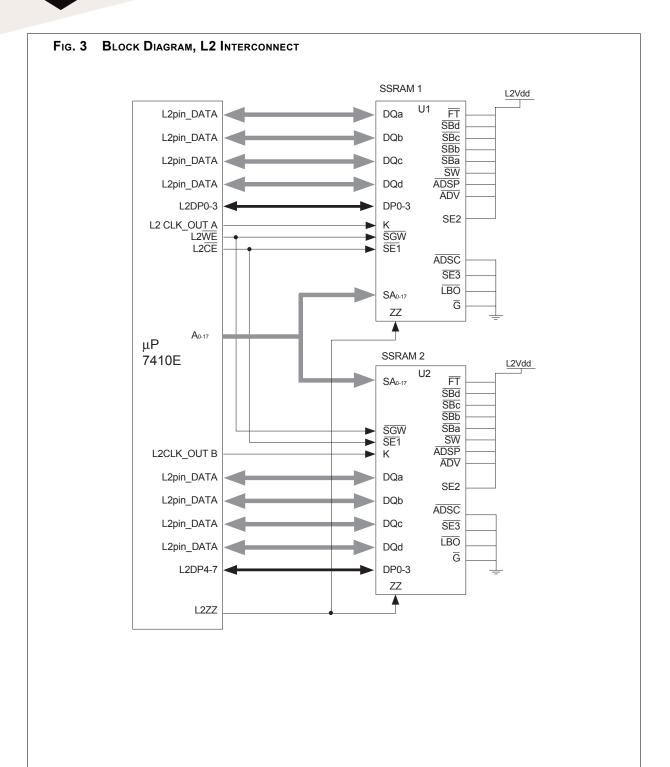
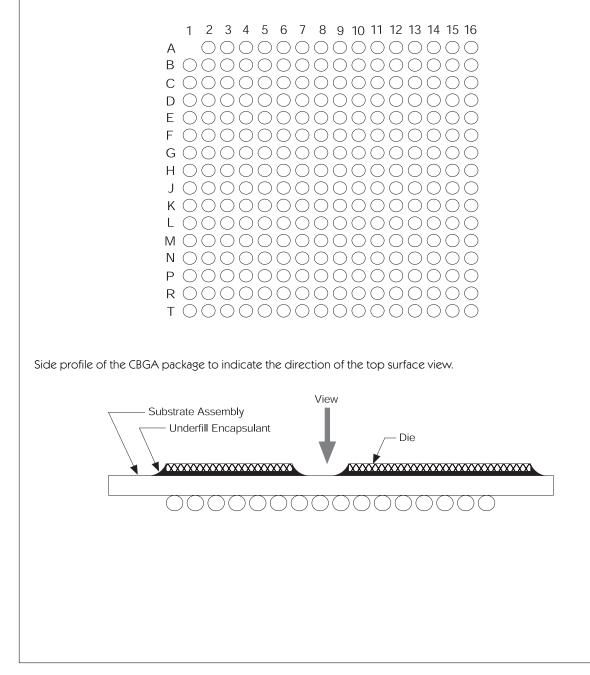


FIG. 5 PIN ASSIGNMENTS

Ball assignments of the 255 CBGA package as viewed from the top surface.



PACKAGE PINOUT LISTING

Signal Name	Pin Number	Active	1/0	1.8V(7)	2.5V(7)	3.3V(7)
A[0-31]	C16, E4, D13, F2, D14, G1, D15, E2, D16, D4, E13, G2, E15, H1, E16, H2, F13, J1, F14,	High	1/0			
	J2, F15, H3, F16, F4, G13, K1, G15, K2, H16, M1, J15, P1					
AACK	12	Low	Input			
ABB/AMONO (8)	K4	Low	Output			
AP[0-3]	C1, B4, B3, B2	High	I/O			
ARTRY	J4	Low	I/O			
AVDD	A10	_	Input	1.8V	1.8V	1.8V
BG	L1	Low	Input			
BR	B6	Low	Output			
BVSEL (4, 6)	B1	High	Input	GND	HRESET	OVDD
CHK (5, 6, 13)	C6	Low	Input			
CI	E1	Low	I/O			
CKSTP_IN	D8	Low	Input			
CKSTP_OUT	Aó	Low	Ouput			
CLK_OUT	D7	High	Output			
DBB/DMONO (8)	J14	Low	Output			
DBG	N1	Low	Input			
DBWO/DTI[0]	G4	Low	Input			
DH[0-31]	P14, T16, R15, T15, R13, R12, P11, N11, R11, T12, T11, R10, P9, N9, T10, R9, T9, P8,	High	1/0			
	N8, R8, T8, N7, R7, T7, P6, N6, R6, T6, R5, N5, T5, T4					
DL[0-31]	K13, K15, K16, L16, L15, L13, L14, M16, M15, M13, N16, N15, N13, N14, P16, P15,	High	1/0			
	R16, R14, T14, N10, P13, N12, T13, P3, N3, N4, R3, T1, T2, P4, T3, R4					
DP[0-7]	M2, L3, N2, L4, R1, P2, M4, R2	High	1/0			
DRDY (5, 9, 12)	D5	Low	Output			
DTI 1-2 (9, 11)	G16, H15	High	Input			
EMODE (10, 11)	C4	Low	Input			
GBL	F1	Low	1/0			
GND	C5, C12, E3, E6, E8, E9, E11, E14, F3, F5, F7, F10, F12, G6, G8, G9, G11, H5, H7, H10, H12,	_	_	GND	GND	GND
	J5, J7, J10, J12, K6, K8, K9, K11, L5, L7, L10, L12, M3, M6, M8, M9, M11, M14, P5, P12					
HIT (5) (12)	A3	Low	Output			
HRESET	A7	Low	Input			
INT	B15	Low	Input			
L1_TSTCLK (1)	D11	High	Input			
L2_TSTCLK (1)	D12	High	Input			
L2AVDD	L11	_	Input	1.8V	1.8V	1.8V
L2VDD (5) (7)	A2, B8, C3, D6, J16	_	Input	3.3V	3.3V	3.3V
L2OVDD	E10, E12, M12, G12, G14, K12, K14	_	Input		2.5V	N/A
L2VSEL (3, 6)	B5	High	Input	*	HRESET	N/A
LSSD_MODE(1)	B10	Low	Input		3.3V	
MCP	C13	Low	Input			
NC (No-connect)	B7, C8	_	_			
OVDD (2)	C7, E5, G3, G5, K3, K5, P7, P10, E7, M5, M7, M10	_	Input	1.8V	2.5V	3.3V
PLL_CFG[0-3]	A8, B9, A9, D9	High	Input			
QACK	D3	Low	Input			
QREQ	J3	Low	Output			
RSRV	D1	Low	Output			
SHD0-1 (5) (14)	A4, A5	Low	I/O			
SMI	A16	Low	Input			
SRESET	B14	Low	Input			

PACKAGE PINOUT LISTING (CONTINUED)

Signal Name	Pin Number	Active	1/0	1.8V(7)	2.5∨(7)	3.3V(7)
SYSCLK	C9	_	Input			
TA	H14	Low	Input			
TBEN	C2	High	Input			
TBST	A14	Low	Output			
TCK	C11	High	Input			
TDI (6)	A11	High	Input			
TDO	A12	High	Output			
TEA	H13	Low	Input			
TMS (6)	B11	High	Input			
TRST (6)	C10	Low	Input			
TS	J13	Low	I/O			
TSIZ[0-2]	A13, D10, B12	High	Output			
TT[0-4]	B13, A15, B16, C14, C15	High	I/O			
VDD (2)	F6, F8, F9, F11, G7, G10, H4, H6, H8, H9, H11, J6, J8, J9, J11, K7, K10, L6, L8, L9	_	Input	1.8V	1.8V	1.8V
WT	D2	Low	I/O			

NOTES:

1. These are test signals for factory use only and must be pulled up to OVdd for normal machine operation.

2. OVdd inputs supply power to the I/O drivers and Vdd inputs supply power to the processor core.

3. To allow future L2 cache I/O interface voltage changes.

4. To allow processor bus 1/0 voltage changes, provide the option to connect BVSEL to HRESET (Selects 2.5V Interface) or to GND (Selects 1.8V

Interface) or to OVDD (Selects 3.3V Interface).

5. Uses one of 9 existing no-connects in WEDC's WED3C755A8M-300BX.

6. Internal pull up on die.

7. OVdd supplies power to the processor bus, JTAG, and all control signals except the L2 cache controls (L2CE, L2WE, and L2ZZ); L2OVDD supplies power to the L2 cache I/O interface (L2ADDR (0-18), L2DATA (0-63), L2DP{0-7} and L2SYNC-OUT) and the L2 control signals; L2AVDD supplies power to the SSRAM core memory; and Vdd supplies power to the processor core and the PLL and DLL (after filtering to become AVDD and L2AVDD respectively). These columns serve as a reference for the nominal voltage supported on a given signal as selected by the BVSEL pin configuration and the voltage supplied. For actual recommended value of Vin or supply voltages see Recommended Operating Conditions. 8. Output only for 7410, was I/O for 750/755.

9. Enhanced mode only.

10. Deasserted (pulled high) at **HRESET** for 60x bus mode.

11. Reuses 750/755 DRTRY, DBIS, and TLBISYNC pins (DTI1, DTI2, and EMODE respectively).

12. Unused output in 60x bus mode.

13. Connect to HRESET to trigger post power-on-reset (por) internal memory test.

14. Ignored in 60x bus mode.

Characteristic		Symbol	Value	Unit	Notes
Core supply voltage		Vdd	-0.3 to 2.1	V	(4)
PLL supply voltage		AVdd	-0.3 to 2.1	V	(4)
L2 DLL supply voltage		L2AVDD	-0.3 to 2.1	V	(4)
60x bus supply voltage		OVdd	-0.3 to 3.465	V	(3)
L2 bus supply voltage		L2OVdd	-0.3 to 2.6	V	(3)
L2 supply voltage		L2Vdd	-0.3 to 4.6	V	(5)
Input supply	Processor Bus	Vin	-0.3 to 0Vdd +0.2	V	(2)
	L2 bus	Vin	-0.3 to L20Vdd +0.2	V	(2)
	JTAG Signals	Vin	-0.3 to OVdd +0.2	V	(2)
Storage temperature rang	e	Tstg	-55 to 150	°C	

ABSOLUTE MAXIMUM RATINGS

NOTES:

1. Functional and tested operating conditions are given in Operating Conditions table. Absolute maximum ratings are stress ratings only, and functional operation at the maximums is not guaranteed. Stresses beyond those listed may affect device reliability or cause permanent damage to the device.

2. Caution: Vin must not exceed OVdd by more than 0.2V at any time including during power-on reset.

3. Caution: OVdd/L2OVDD must not exceed Vdd/AVdd/L2AVdd by more than 2.0 V at any time including during power-on reset.

4. Caution: Vdd/AVdd/L2AVDD must not exceed L2OVdd/OVdd by more than 0.4 V at any time including during power-on reset.

5. L2OVdd should never exceed L2Vdd

RECOMMENDED OPERATING CONDITIONS

Characteristic		Symbol	Recommended Value	Unit
Core supply voltage		Vdd	$1.8v \pm 100mV$	V
PLL supply voltage		AVdd	$1.8v \pm 100mV$	V
L2 DLL supply voltage		L2AVdd	$1.8v \pm 100mV$	V
Memory core supply voltage		L2Vdd	3.3v ± 165mV	V
	BVSEL = 0	OVdd	1.8± 100mV	\vee
Processor bus supply voltage	$BVSEL = \overline{HRESET}$	OVdd	$2.5v \pm 100mV$	\vee
	BVSEL = HRESET or BVSEL=1	OVdd	$3.3v \pm 165 \text{ mV}$	\vee
L2 bus supply voltage	L2VSEL = HRESET or 1	L20Vdd	2.5v ± 100 mV	V
Input Voltage	Processor bus and JTAG Signals	Vin	GND to OVdd	V

NOTE:

These are the recommended and tested operating conditions. Proper device operation outside of these conditions is not guaranteed

POWER CONSUMPTION VDD=AVDD=1.8±0.1V VDC, L2VDD=3.3V ±5% VDC, GND=0 VDC, 0≤TJ<105°C

		Processor (CPU) Frequency/L2 Frequency 400 MHz/200MHz	Unit	Notes
Full-on Mode	Typical	5.7	W	1, 3
	Maximum	13.5	W	1, 2
Doze Mode	Maximum	5.3	W	1, 2
Nap Mode	Maximum	2.25	W	1, 2
Sleep Mode	Maximum	2.20	W	1, 2
Sleep Mode–PLL and DLL Disabled	Maximum	2.0	W	1, 2

NOTES:

1. These values apply for all valid system bus and L2 bus ratios. The values do not include OVdd; AVdd and L2AVdd suppling power. OVdd power is

system dependent, but is typically <10% of Vdd power. Worst case power consumption, for AVdd=15mW and L2AVdd=15mW. 2. Maximum power is measured at Vdd=1.9 V while running an entirely cache-resident, contrived sequence of instructions which keep the execution

units maximally busy. 3. Typical power is an average value measured at Vdd=AVdd=L2AVdd=1.8V, OVddd=L2OVdd=2.5V in a system, executing typical applications and benchmark sequences.

L2 CACHE CONTROL REGISTER (L2CR)

The L2 cache control register, shown in Figure 5, is a supervisor-level, implementation-specific SPR used to configure and operate the L2 cache. It is cleared by hard reset or power-on reset.

FIG. 5 L2 CACHE CONTROL REGISTER (L2CR)

										LS	2WT				L2D	F	L2F/	۹.	L2(CLK	STP				
L2F	ΡĒ						LS	2DO	L	2ÇTL	. L!	2TS		L2ŞL	L	2BYP	L2	HWF	L2IO	С	L2D	RO			
L2IP																								 	
L2E		L25	SIZ	L2C	LK	L2R	AM		L21				L20	н									0000000		
0 1		2	3	4	6	7	8	9	10	11	12	13	14 1	1516	17	18	19	20	21	22	2 23	24		30	31
Thel	\sim	Dhi	tc a	re de	ccrib	ed i	n Ta	hle	1																

The LYCK bits are described in Table T.

Bit Name Function 0 19F L2 enable. Enables L2 cache operation (including snooping) starting with the next transaction the L2 cache unit receives. Before enabling the L2 cache, the L2 clock must be configured through L2CR[2CLK], and the L2 DLL must stabilize. All other L2CR bits must be set appropriately. The L2 cache may need to be invalidated globally. 1 L2PE L2 data parity checking enable. Enables parity generation and checking for the L2 data RAM interface. When disabled, generated parity is always zeros. L2 Parity is supported by WEDC's WED3C7410E16M-400BX, but is dependent on application. 19517 0_3 L2 size—Should be set according to the size of the private memory setting. Total SRAM space is 2M bytes (256Kx72). See L2 cache/private memory configurations table in Motorola User's Manual. 4-6 L9CLK L2 clock ratio (core-to-L2 frequency divider). Specifies the clock divider ratio based from the core clock frequency that the L2 data RAM interface is to operate at. When these bits are cleared, the L2 clock is stopped and the on-chip DLL for the L2 interface is disabled. For nonzero values, the processor generates the L2 clock and the on-chip DLL is enabled. After the L2 clock ratio is chosen, the DLL must stabilize before the L2 interface can be enabled. The resulting L2 clock frequency cannot be slower than the clock frequency of the 60x bus interface. 000 L2 clock and DLL disabled 001 ÷ 1 010 ÷ 1.5 011 ÷ 3.5 100 + 2 101 ÷ 2.5 ÷ 3 110 111 ÷ 4 7-8 L2RAM L2 RAM type—Configures the L2 RAM interface for the type of synchronous SRAMs used: Pipelined (register-register) synchronous burst SRAMs that clock addresses in and clock data out The 7410 does not burst data into the L2 cache, it generates an address for each access. 10: Pipelined (register-register) synchronous burst SRAM - Setting for WED3C7410E16M-400BX 9 1900 L2 data only. Setting this bit enablesÚdata-only operation in the L2 cache. When this bit is set, only transactions from the L1 data cache can be cached in the L2 cache. L1 instruction cache operations will be serviced for instruction addresses already in the L2 cache; however, the L2 cache will not be reloaded for L1 instruction cache misses. Note that setting both L2DO and L2IO effectively locks the 19 cache 191 10 L2 global invalidate. Setting L2I invalidates the L2 cache globally by clearing the L2 status bits. This bit must not be set while the L2 cache is enabled. See Motorola's User manual for L2 Invalidation procedure. 11 L2CTL L2 RAM control (ZZ enable). Setting L2CTL enables the automatic operation of the L2ZZ (low-power mode) signal for cache RAMs. Sleep mode is supported by the WED3C7410E16M-400BX. While L2CTL is asserted, L2ZZ asserts automatically when the device enters nap or sleep mode and negates automatically when the device exits nap or sleep mode. This bit should not be set when the device is in nap mode and snooping is to be performed through deassertion of QACK. 12 L9WT L2 write-through. Setting L2WT selects write-through mode (rather than the default write-back mode) so all writes to the L2 cache also write through to the system bus. For these writes, the L2 cache entry is always marked as clean (value unmodified) rather than dirty (value modified). This bit must never be asserted after the L2 cache has been enabled as previously-modified lines can get remarked as clean (value unmodified) during normal operation. L2TS 13 L2 test support. Setting L2TS causes cache block pushes from the L1 data cache that result from dcbf and dcbst instructions to be written only into the L2 cache and marked valid, rather than being written only to the system bus and marked invalid in the L2 cache in case of hit. This bit allows a dcbz/dcbf instruction sequence to be used with the L1 cache enabled to easily initialize the L2 cache with any address and data information. This bit also keeps **dcbz** instructions from being broadcast on the system and single-beat cacheable store misses in the L2 from being written to the system bus. 14 - 15L2OH L2 output hold. These bits configure output hold time for address, data, and control signals driven to the L2 data RAMs. 01: 0.8ns Hold Time - Setting for WED3C7410E16M-400BX

TABLE 1: L2CR BIT SETTINGS

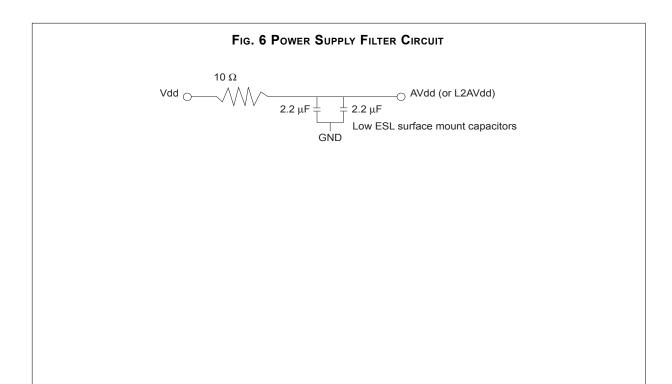
White Electronic Designs Corporation • (602) 437-1520 • www.whiteedc.com

Bit	Name	Function
16	L2SL	L2 DLL slow. Setting L2SL increases the delay of each tap of the DLL delay line. It is intended to increase the delay through the DLL to accommodate slower L2 RAM bus frequencies.
		0: Setting for WED3C7410E16M-400BX because L2 RAM interface is operated above 100 MHz.
17	L2DF	L2 differential clock. This mode supports the differential clock requirements of late-write SRAMs.
		0: Setting for WED3C7410E16M-400BX because late-write SRAMs are not used.
18	L2BYP	L2 DLL bypass is reserved.
		0: Setting for WED3C7410E16M-400BX
19	L2FA	L2 flush assist (for software flush). When this bit is negated, all lines castout from the dL1 which have a state of CDMRSV=01xxx1
		(i.e. C-bit negated), will not allocate in the L2 if they miss. Asserting this bit forces every castout from the dL1 to allocate an entry in the
		L2 if that castout misses in the L2 regardless of the state of the C-bit. The L2FA bit must be set and the L2IO bit must be cleared in order to
		use the software flush algorithm.
20	L2HWF	L2 hardware flush. When the processor detects the value of L2HWF set to 1, the L2 will begin a hardware flush. The flush will be done by
		starting with low cache indices and increment these indices for way 0 of the cache, one index at a time until the maximum index value
		is obtained. Then, the index will be cleared to zero and the same process is repeated for way 1 of the cache. For each index and way of
		the cache, the processor will generate a castout operation to the system bus for all modified 32-byte sectors. At the end of the hardware
		flush, all lines in the L2 tag will be invalidated. During the flush, all memory activity from the icache and dcache are blocked from accessing
		the L2 until the flush is complete. Snoops, however, are fully serviced by the L2 during the flush. When the L2 tags have been fully flushed
		of all valid entries, this bit will be reset to b'0" by hardware. When this bit is cleared, it does not necessarily guarantee that all lines form
		the L2 have been written completely to the system interface. L2 copybacks can still be queued in the bus interface unit. Below is the code
		which must be run to use L2 Hardware Flush. When the final sync completes, all modified lines in the L2 will have been written to the system
		address bus.
		Disable interrupts
		dssall
		sync
		set L2HWF
		sync
21	L2IO	L2 Instruction-Only. Setting this bit enales instruction-only operation in the L2 cache. For this operation, only transactions from the L1
		instruction cache are allowed to be reloaded in the L2 cache. Data addresses already in the cache will still hit for the L1 data cache. When
		both L2DO and L2IO are asserted, the L2 cache is effectively locked.
22	L2CLKSTP	L2 Clock Stop. Setting this bit enables the automatic stopping of the L2CLK OUT signals for cache rams that support this function. While
		L2CLKSTP is set, the L2CLK OUT signals will automatically be stopped when WED3C7410E16M-400BX enters nap or sleep mode, and
		automatically restarted when WED3C7410E16M-400BX exits nap or sleep.
23	L2DRO	L2 DLL rollover. Setting this bit enables a potential rollover (or actual rollover) condition of the DLL to cause a checkstop for the processor.
20	LEDRO	A potential rollover condition occurs when the DLL is selecting the last tap of the delay line, and thus may risk rolling over to the first tap with
		one adjustment while in the process of keeping synchronized. Such a condition is improper operation for the DLL, and, while this condition is
		not expected, it allows detection for added security. This bit can be set when the DLL is first enabled (set with the L2CLK bits) to detect
01 20		rollover during initial synchronization. It could also be set when the L2 cache is enabled (with L2E bit) after the DLL has achieved its initial lock.
24-30	-	Reserved
31	L2IP	L2 global invalidate in progress (read only)—See the Motorola user's manual for L2 Invalidation procedure.

TABLE 1: L2CR BIT SETTINGS

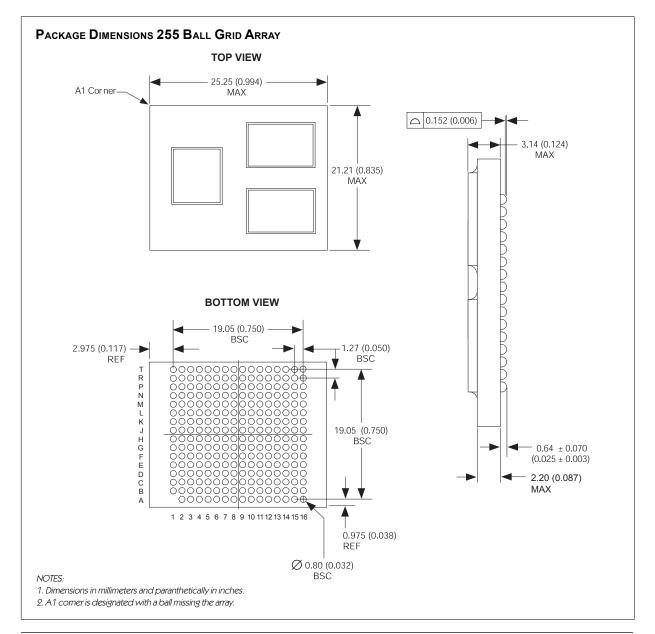
PLL POWER SUPPLY FILTERING

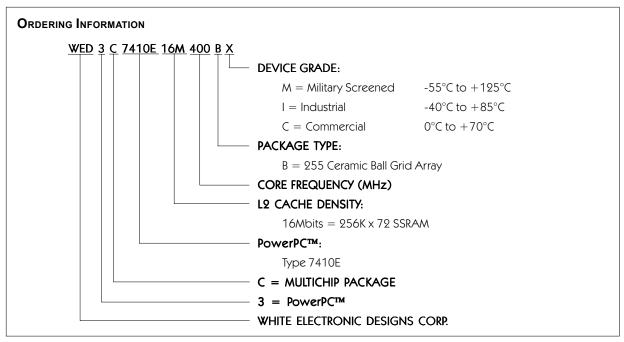
The AVdd and L2AVdd power signals are provided on the WED3C7410E16M-400BX to provide power to the clock generation phase-locked loop and L2 cache delay-locked loop respectively. To ensure stability of the internal clock, the power supplied to the AVdd input signal should be filtered of any noise in the 500kHz to 10 MHz resonant frequency range of the PLL. A circuit similar to the one shown in Figure 6 using surface mount capacitors with minimum Effective Series Inductance (ESL) is recommended. Multiple small capacitors of equal value are recommended over a single large value capacitor. The circuit should be placed as close as possible to the AVdd pin to minimize noise coupled from nearby circuits. An identical but separate circuit should be placed as close as possible to the L2AVdd pin. It is often possible to route directly from the capacitors to the AVdd pin, which is on the periphery of the 255 BGA footprint, without the inductance of vias. The L2AVdd pin may be more difficult to route but is proportionately less critical.



PACKAGE DESCRIPTION

Package Outline	21x25mm
Interconnects	255 (16x16 ball array less one)
Pitch	1.27mm
Maximum module height	3.90mm
Ball diameter	0.8mm





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